

# Search Notes



Application/Control No.

10/684,771

Examiner

Pablo N. Tran

Applicant(s)/Patent under Reexamination

SENDONARIS ET AL.

Art Unit

2618

## SEARCHED

Class	Subclass	Date	Examiner
2155	255	05/25/00	PL
	260		
	265		
	552.1		
	259		
	180.3		
	182.1		
	183.1		
	184.1		
	190.		
	192.1		
	192.2		
	313		
375	362		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Lat/mest	05/25/00	PL

**Search Notes (continued)**


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**SEARCHED**

Class	Subclass	Date	Examiner
378	372	09/28/06	PL
	376		
	187		
342	387		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR